

APPROVAL SHEET

WLPN505040 Series SMD Shielded Power Inductors



*Contents in this sheet are subject to change without prior notice.

Features

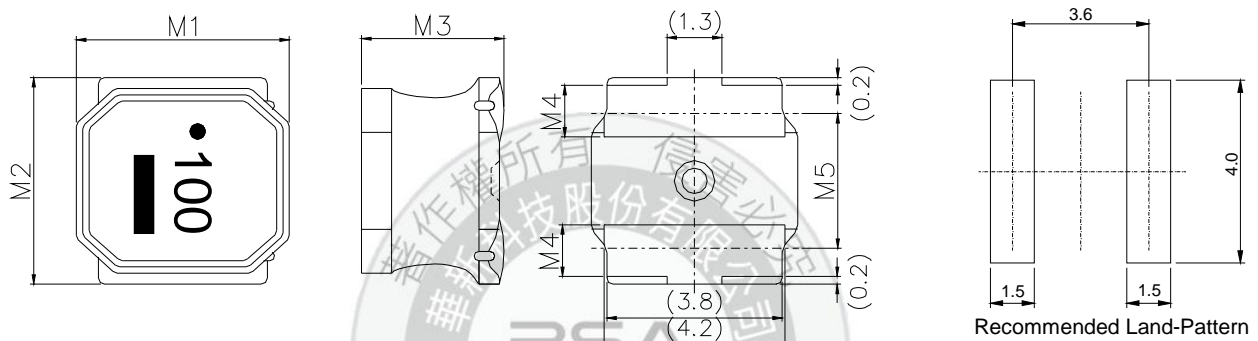
1. Close magnetic loop with magnetic resin shielded.
2. High inductance.

Applications

1. General propose power inductor in DC power system.
2. Inductor in DC/DC converter.
3. LC filter in Audio D class Amplifier.
4. Use in STB、Notebook、Radio、LCDs、other electrical devices.

Shape and Dimension

Unit: mm



Package Size	M1	M2	M3 (N1R5-M100)	M3 (M150-M470)	M4	M5
WLPN505040	4.9±0.2	4.9±0.2	4.1 MAX.	4.0 MAX.	1.2±0.2	3.3±0.2

Ordering Information

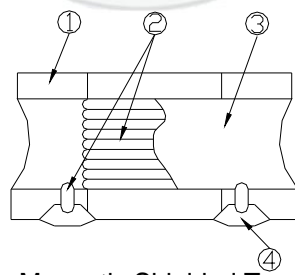
WL	PN	5050	40	N	1R5	L	B
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	SMD Shielded Power Inductors	4.9 * 4.9 mm	4.1 mm	M: ± 20% N: ± 30%	1R5 = 1.5uH 150 = 15.0uH	L=13" Reeled (Embossed tape)	B:STD

Electrical Characteristics

WLPN505040 Series	L (uH)	Inductance Tolerance	Test Freq (KHz)	DCR (Ω) $\pm 20\%$.	SRF Min. (MHz)	Rated Current (mA)	
						Saturation Current Idc1	Temperature Rise Current Idc2
WLPN505040N1R5LB	1.5	N	100	0.017	60	6400	4500
WLPN505040N2R2LB	2.2	N	100	0.022	42	5000	3700
WLPN505040N3R3LB	3.3	N	100	0.027	32	4000	3300
WLPN505040N4R7LB	4.7	N	100	0.029	28	3300	3100
WLPN505040M6R8LB	6.8	M	100	0.049	21	2800	2400
WLPN505040M100LB	10	M	100	0.056	18	2300	2100
WLPN505040M150LB	15	M	100	0.080	13	2000	1800
WLPN505040M220LB	22	M	100	0.126	9	1500	1400
WLPN505040M330LB	33	M	100	0.180	7	1300	1200
WLPN505040M470LB	47	M	100	0.310	6	1100	900

1. Test Frequency: 100KHz
2. Test Equipment:
Inductance: Chroma3302+1320+16502. or equivalent.
DCR: Chroma16502 or equivalent.
SRF: HP4291B or equivalent.
3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.
4. Temperature rise current Idc2: The value of current causes a 40°C temperature rise.
5. Rated Current: Either Idc1 or Idc2 whichever is smaller.
6. Operating Temperature Range: -25°C to +125°C (Including self-temperature rise)
7. Storage Temp. Range : -40°C to +85°C.
8. MSL : Level 1

Structural Drawing:

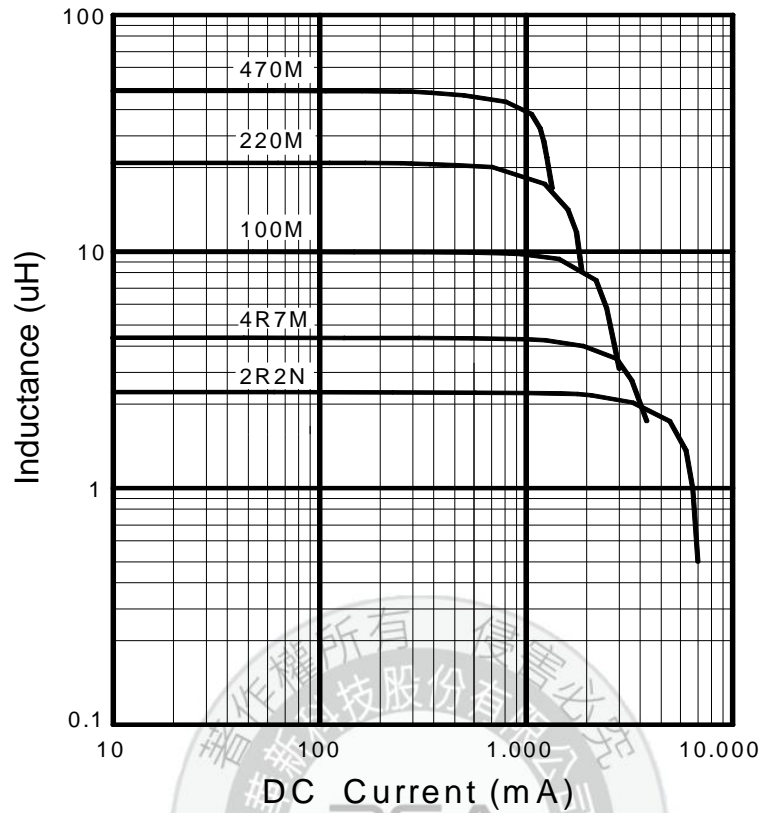


Magnetic Shielded Type

- | | |
|-----------------------|--|
| ① Ferrite core. | Ni-Zn ferrite |
| ② Winding wire | Polyurethane-copper wire |
| ③ Over-coating resin. | Epoxy resin, containing ferrite powder |
| ④ Electrode | External electrode (substrate) Ag
External electrode (base plating) Ni-Sn
External electrode (top surface solder coating) Sn-Ag-Cu |

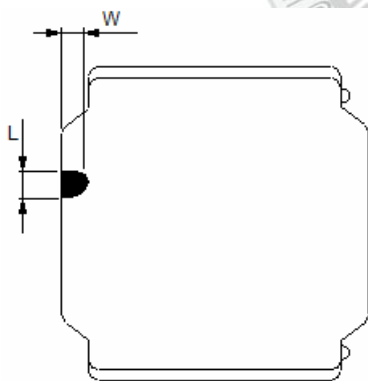
ELECTRICAL CURVE

Inductance vs. DC Current

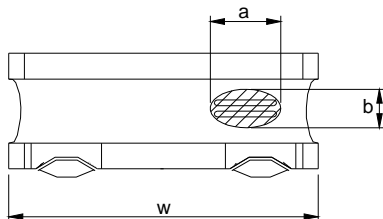


Core Chipping

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.

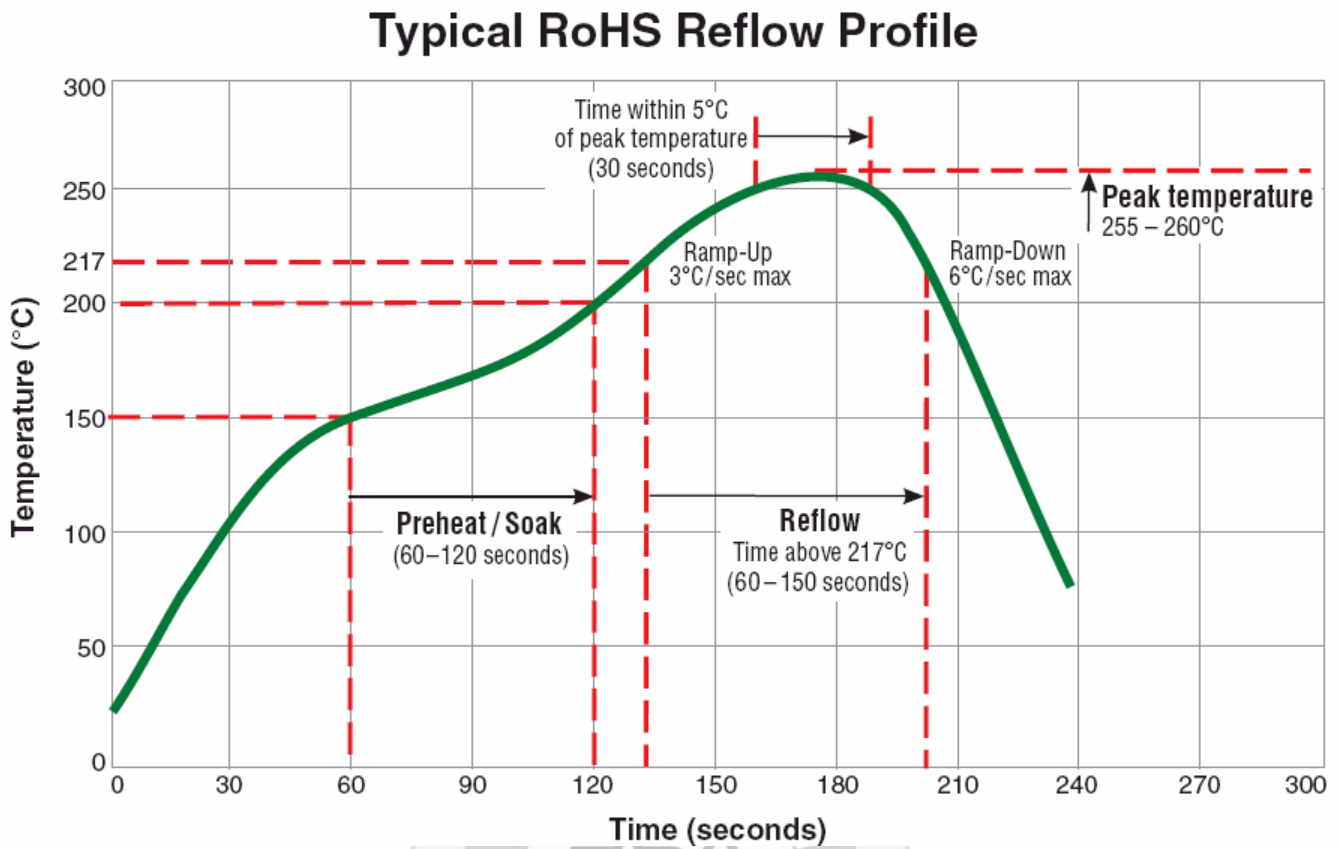


L	W
1.5mmMax.	1.5mmMax.

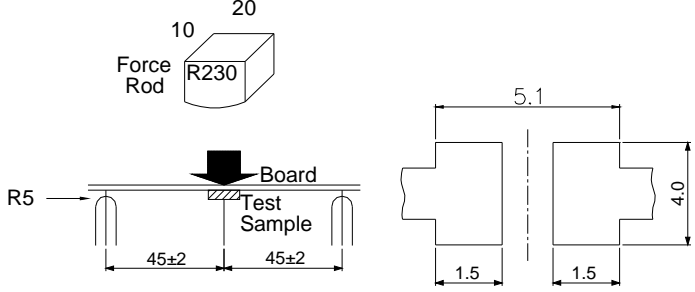
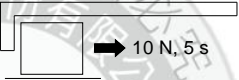
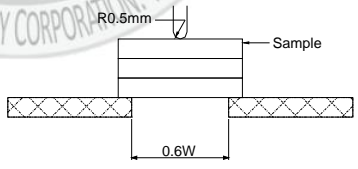


- ① Width direction (dimension a): Acceptable when $a \leq w/2$
Nonconforming when $a > w/2$
- ② Length direction (dimension b): Dimension b is not specified.
- ③ When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

TYPICAL RoHS REFLOW PROFILE



Mechanical Performance /Environmental Test Performance Specifications: (WLPN505040 series)

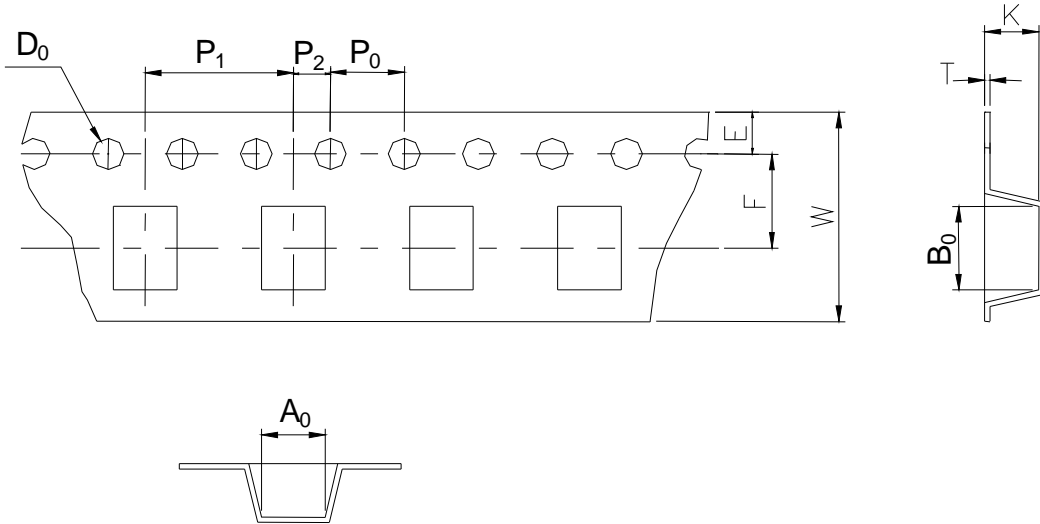
	Test Item	Standard	Test method
MECHANICAL CHARACTERISTICS	Resistance to Deflection	No damage.	 <p>The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicating until deflection of the test board Reaches to 2 mm.</p> <p style="text-align: right;">Land dimensions</p> <p>Test board size :100×40×10 Test board material I: glass epoxy-resin Solder cream thickness:0.1 Unit: mm</p>
	Adhesion of Terminal Electrode	Shall not come off PC board	 <p>The test samples shall be soldered to the test board By the reflow soldering conditions shown in Table 1.</p> <p>Applied force:10 N to X and Y directions Duration:5 s. Solder cream thickness:0.1 mm (Refer to recommended Land Pattern Dimensions Defined in "Precaution")</p>
	Body strength	No damage	 <p>Applied force :20 N Duration :10 s</p>

Test Item	Standard	Test method															
Resistance to Vibration	Δ L/L:within \pm 10% No abnormality observed In appearance	The test samples shall be soldered to the test board by The reflow soldering conditions shown in Table 1.Then It shall be submitted to below test conditions <table border="1"> <tr> <td>Frequency range</td> <td>10Hz~55Hz</td> </tr> <tr> <td>Total Amplitude</td> <td>1.5mm(May not exceed acceleration 196 m/S²)</td> </tr> <tr> <td>Sweeping Method</td> <td>10Hz to 55Hz to 10 Hz for 1 min.</td> </tr> <tr> <td>Time</td> <td>For 2 hours on each X,Y, and Z axis.</td> </tr> </table>	Frequency range	10Hz~55Hz	Total Amplitude	1.5mm(May not exceed acceleration 196 m/S ²)	Sweeping Method	10Hz to 55Hz to 10 Hz for 1 min.	Time	For 2 hours on each X,Y, and Z axis.							
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Time	For 2 hours on each X,Y, and Z axis.																
Resistance to Soldering heat (Reflow)	Δ L/L:within \pm 10% No abnormality observed In appearance	The test sample shall be exposed to reflow oven at 230 \pm 5 deg C for 40 seconds, with peak temperature at 260 \pm 5 deg C for 5 seconds, 2 times. Test board thickness:1.0 mm Test board material :glass epoxy-resin															
Solder ability	At least 90% of surface of terminal electrode is covered by new solder.	The test samples shall be dipped in flux, and then Immersed in molten solder as shown in below table. Flux: Methanol solution containing rosin 25% <table border="1"> <tr> <td>Solder Temperature</td> <td>245\pmdeg C</td> </tr> <tr> <td>Time</td> <td>5\pm1.0 S.</td> </tr> <tr> <td>Immersing Speed</td> <td>25 mm/s</td> </tr> </table>	Solder Temperature	245 \pm deg C	Time	5 \pm 1.0 S.	Immersing Speed	25 mm/s									
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Time	5 \pm 1.0 S.																
Immersing Speed	25 mm/s																
Temperature Characteristics	Δ L/L:within \pm 20% No abnormality observed In appearance	Measurement of inductance shall be taken at temperature Range within -25 deg C to +85 deg C. With reference to inductance value at +20 deg C, change Rate shall be calculated.															
Thermal shock	Δ L/L:within \pm 10% No abnormality observed In appearance	The test samples shall be soldered to test board By the reflow soldering conditions shown in Table 1. The test samples shall be placed at specified Shown in below table in sequence. The temperature cycle shall be repeated 100 cycles. Conditions of steps for 1 cycle <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature</th> <th>Time(min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>-40\pm3 deg C</td> <td>30\pm3</td> </tr> <tr> <td>2</td> <td>Room Temp</td> <td>3 maximum</td> </tr> <tr> <td>3</td> <td>85\pm2 deg C</td> <td>30\pm3</td> </tr> <tr> <td>4</td> <td>Room Temp</td> <td>3 maximum</td> </tr> </tbody> </table>	Step	Temperature	Time(min)	1	-40 \pm 3 deg C	30 \pm 3	2	Room Temp	3 maximum	3	85 \pm 2 deg C	30 \pm 3	4	Room Temp	3 maximum
Step	Temperature	Time(min)															
1	-40 \pm 3 deg C	30 \pm 3															
2	Room Temp	3 maximum															
3	85 \pm 2 deg C	30 \pm 3															
4	Room Temp	3 maximum															
Low Temperature life Test	Δ L/L:within \pm 10% No abnormality observed In appearance	The test samples shall be soldered to the test board by The reflow soldering conditions shown in Table 1. After that, the test samples shall be placed at test Conditions as shown in below table. <table border="1"> <tr> <td>Temperature</td> <td>-40\pm2 deg C</td> </tr> <tr> <td>Time</td> <td>500 +24/-0 h</td> </tr> </table>	Temperature	-40 \pm 2 deg C	Time	500 +24/-0 h											
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Time	500 +24/-0 h																

	Test Item	Standard	Test method							
ENVIRONMENT TESTS	Loading at high temperature life test	$\Delta L/L$: within $\pm 10\%$ No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table. <table border="1" style="margin-left: auto; margin-right: auto;"> <tr> <td>Temperature</td> <td>85\pm2 deg C</td> </tr> <tr> <td>Applied current</td> <td>Rated current (Refer to Page 3)</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	85 \pm 2 deg C	Applied current	Rated current (Refer to Page 3)	Time	500+24/-0 h	
	Temperature	85 \pm 2 deg C								
	Applied current	Rated current (Refer to Page 3)								
Time	500+24/-0 h									
Damp heat life test	$\Delta L/L$: within $\pm 10\%$ No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below table. <table border="1" style="margin-left: auto; margin-right: auto;"> <tr> <td>Temperature</td> <td>60\pm2 deg C</td> </tr> <tr> <td>Humidity</td> <td>90~95%RH</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	60 \pm 2 deg C	Humidity	90~95%RH	Time	500+24/-0 h		
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Loading under Damp heat life test	$\Delta L/L$: within $\pm 10\%$ No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table. <table border="1" style="margin-left: auto; margin-right: auto;"> <tr> <td>Temperature</td> <td>60\pm2 deg C</td> </tr> <tr> <td>Humidity</td> <td>90~95%RH</td> </tr> <tr> <td>Applied current</td> <td>Rated current (Refer to Page 3)</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	60 \pm 2 deg C	Humidity	90~95%RH	Applied current	Rated current (Refer to Page 3)	Time	500+24/-0 h
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Humidity	90~95%RH									
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Tape & Reel Packaging Dimensions:

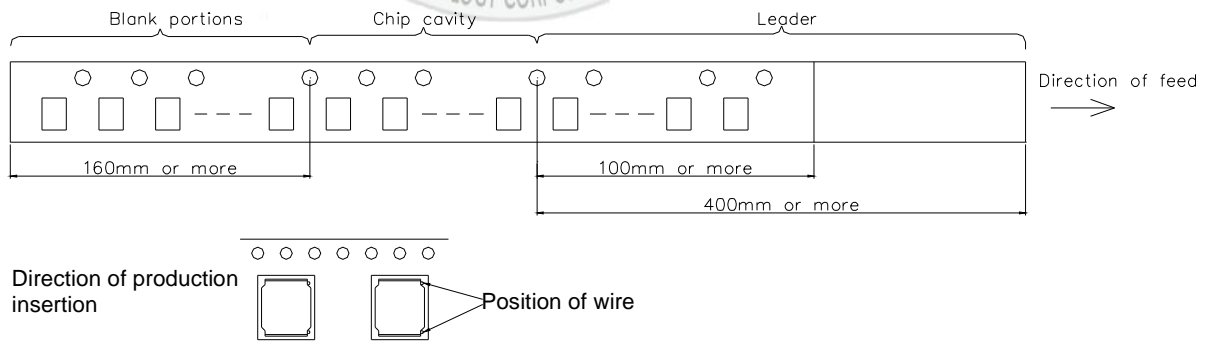
Dimensions



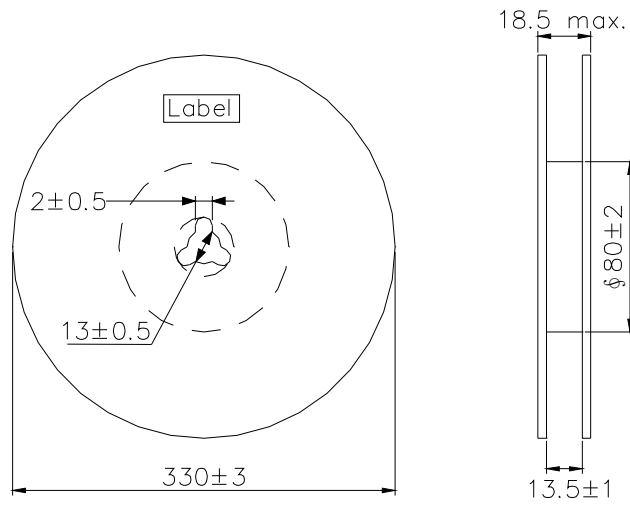
Unit : mm

A_0	B_0	W	F	E	P_1	P_2	P_0	D_0	T	K
5.15 ± 0.1	5.15 ± 0.1	12.0 ± 0.3	5.5 ± 0.1	1.75 ± 0.1	8.0 ± 0.1	2.0 ± 0.1	4.0 ± 0.1	$\Phi 1.5$ $+0.1$ -0	0.4 ± 0.1	4.2 ± 0.1

Direction of rolling

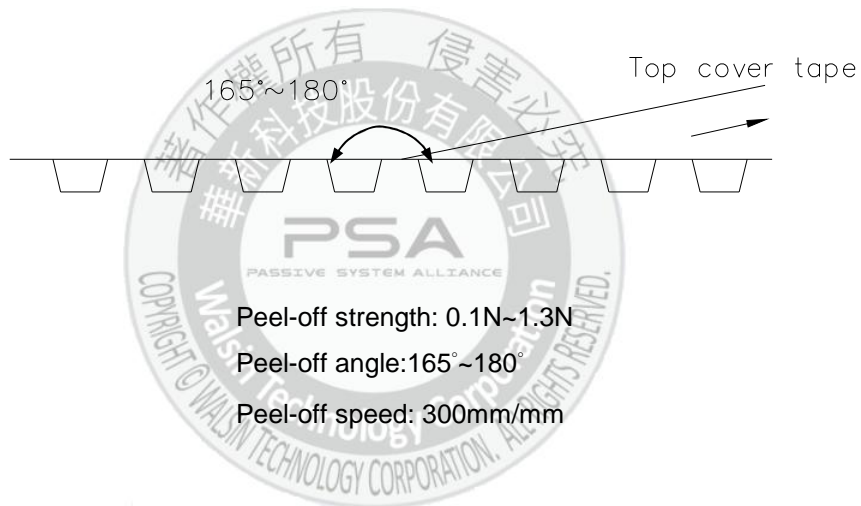


Reel



Label position: on the opposite side of sprocket holes side of reel

Top tape strength



Quantity per reel : 1.5K pcs